



COPY OF PAPERS
ORIGINALLY FILED

28TT 45
7.18 2

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Re Application of

Atty. Docket

RENE MONSHOUWER ET AL

NL 000771

Serial No. 09/940,818

Group Art Unit: 287

Filed: AUGUST 28, 2001

Ex.:

Title: METHOD OF MEASURING OVERLAY

Commissioner for Patents
Washington, D.C. 20231

RECEIVED
TECHNOLOGY CENTER 2800
JUL -9 2001

INFORMATION DISCLOSURE STATEMENT UNDER 37 C.F.R. 1.97

Sir:

Enclosed is a copy of a foreign search report issued in a related application. The documents cited are "A" (technical background) only.

Respectfully submitted,

By 
Aaron Waxler, Reg. 48,027
(914) 333-9608

CERTIFICATE OF MAILING

I hereby certify that this correspondence is being deposited this date with the United States Postal Service as first-class mail in an envelope addressed to:
COMMISSIONER OF PATENTS AND TRADEMARKS
Washington, D.C. 20231

On June 27, 2002
(Mailing Date)

By Bennett Jones
(Signature)

